

Complementary Silicon Power Plastic Transistors

 \dots designed for low voltage, low–power, high–gain audio amplifier applications.

• Collector–Emitter Sustaining Voltage —

$$V_{CEO(sus)} = 25 \text{ Vdc (Min)} @ I_C = 10 \text{ mAdc}$$

• High DC Current Gain —

• Low Collector–Emitter Saturation Voltage —

$$V_{CE(sat)} = 0.3 \text{ Vdc (Max)} @ I_{C} = 500 \text{ mAdc}$$

= 0.75 Vdc (Max) @ I_{C} = 2.0 Adc

• High Current-Gain — Bandwidth Product —

• Annular Construction for Low Leakage —

MAXIMUM RATINGS

Rating	Symbol	Value	Unit	
Collector-Base Voltage	V _{CB}	40	Vdc	
Collector–Emitter Voltage	VCEO	25	Vdc	
Emitter–Base Voltage	VEB	8.0	Vdc	
Collector Current — Continuous Peak	IC	5.0 10	Adc	
Base Current	ΙΒ	1.0	Adc	
Total Power Dissipation @ T _C = 25°C Derate above 25°C	P _D	15 0.12	Watts W/°C	
Total Power Dissipation @ T _A = 25°C Derate above 25°C	PD	1.5 0.012	Watts W/°C	
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +150	°C	

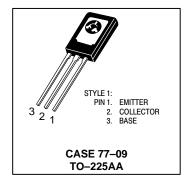
THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	θJC	8.34	°C/W
Thermal Resistance, Junction to Ambient	$\theta_{\sf JA}$	83.4	°C/W

MJE200* PNP MJE210*

*ON Semiconductor Preferred Device

5 AMPERE
POWER TRANSISTORS
COMPLEMENTARY
SILICON
25 VOLTS
15 WATTS



Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

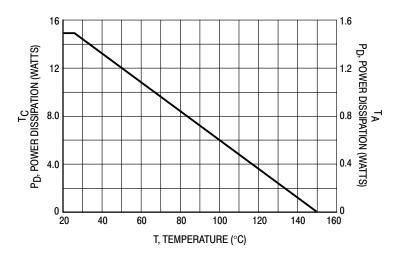
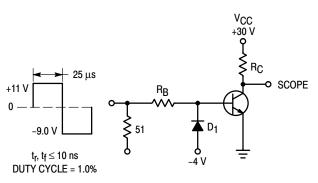


Figure 1. Power Derating

FI FCTRICAL CHARACTERISTICS (To = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Max	Unit
OFF CHARACTERISTICS				•	
Collector–Emitter Sustaining Voltage (1) (I _C = 10 mAdc, I _B = 0)		VCEO(sus)	25	_	Vdc
Collector Cutoff Current (V _{CB} = 40 Vdc, I _E = 0) (V _{CB} = 40 Vdc, I _E = 0, T _J = 125°C)		ICBO	_	100 100	nAdc μAdc
Emitter Cutoff Current (V _{BE} = 8.0 Vdc, I _C = 0)		IEBO	_	100	nAdc
ON CHARACTERISTICS					
DC Current Gain (1) (I _C = 500 mAdc, V _{CE} = 1.0 Vdc) (I _C = 2.0 Adc, V _{CE} = 1.0 Vdc) (I _C = 5.0 Adc, V _{CE} = 2.0 Vdc)		hFE	70 45 10	 180 	_
Collector–Emitter Saturation Voltage (1) (I _C = 500 mAdc, I _B = 50 mAdc) (I _C = 2.0 Adc, I _B = 200 mAdc) (I _C = 5.0 Adc, I _B = 1.0 Adc)		VCE(sat)	=	0.3 0.75 1.8	Vdc
Base–Emitter Saturation Voltage (1) (I _C = 5.0 Adc, I _B = 1.0 Adc)		V _{BE(sat)}	_	2.5	Vdc
Base–Emitter On Voltage (1) (I _C = 2.0 Adc, V _{CE} = 1.0 Vdc)		V _{BE(on)}	_	1.6	Vdc
DYNAMIC CHARACTERISTICS					
Current–Gain — Bandwidth Product (2) (I _C = 100 mAdc, V _{CE} = 10 Vdc, f _{test} = 10 MHz)		fT	65	_	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f = 0.1 MHz)	MJE200 MJE210	C _{ob}	_	80 120	pF

⁽¹⁾ Pulse Test: Pulse Width = 300 μ s, Duty Cycle \approx 2.0%. (2) $f_T = |h_{fe}| \cdot f_{test}$.



 R_B and R_C Varied to obtain desired current levels D₁ MUST be fast recovery type, e.g.: 1N5825 USED ABOVE I_B \approx 100 mA MSD6100 USED BELOW I_B \approx 100 mA

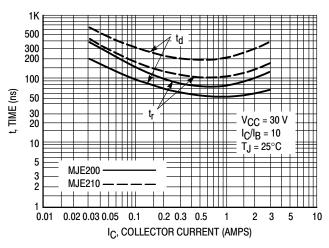


Figure 2. Switching Time Test Circuit

Figure 3. Turn-On Time

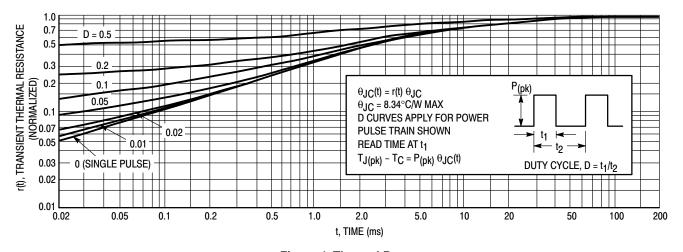


Figure 4. Thermal Response

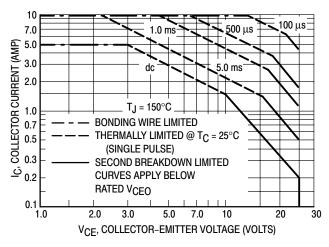


Figure 5. Active Region Safe Operating Area

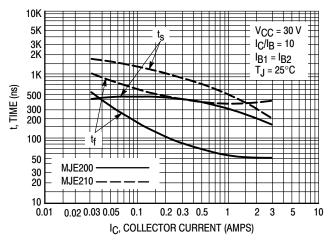


Figure 6. Turn-Off Time

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 5 is based on $T_{J(pk)} = 150^{\circ}C$; T_{C} is variable depending on conditions. Second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(pk)} \le 150^{\circ}C$. $T_{J(pk)}$ may be calculated from the data in Figure 4. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

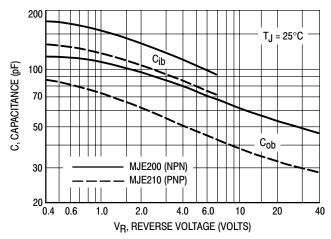


Figure 7. Capacitance

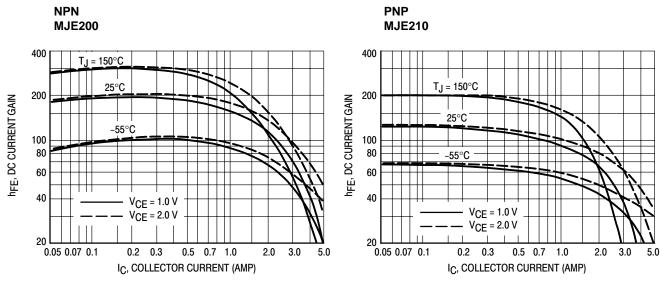


Figure 8. DC Current Gain

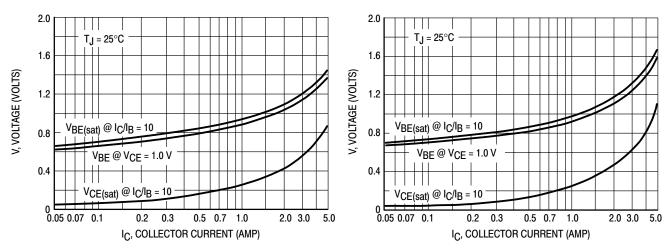


Figure 9. "On" Voltage

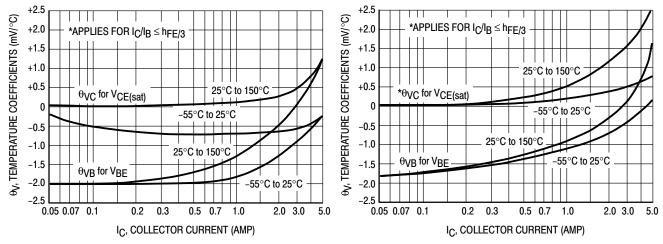
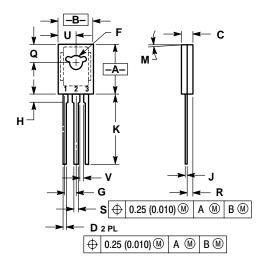


Figure 10. Temperature Coefficients

PACKAGE DIMENSIONS

TO-225AA **CASE 77-09 ISSUE W**



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.425	0.435	10.80	11.04	
В	0.295	0.305	7.50	7.74	
С	0.095	0.105	2.42	2.66	
D	0.020	0.026	0.51	0.66	
F	0.115	0.130	2.93	3.30	
G	0.094 BSC		2.39 BSC		
Н	0.050	0.095	1.27	2.41	
J	0.015	0.025	0.39	0.63	
K	0.575	0.655	14.61	16.63	
M	5°	TYP	5°	5° TYP	
Q	0.148	0.158	3.76	4.01	
R	0.045	0.065	1.15	1.65	
S	0.025	0.035	0.64	0.88	
U	0.145	0.155	3.69	3.93	
٧	0.040		1.02		

STYLE 1:
PIN 1. EMITTER
2. COLLECTOR
3. BASE



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